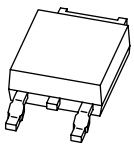


BT151S series

Thyristors

Rev. 04 — 9 June 2004 Product data sheet

1. Product profile

1.1 General description

Passivated thyristors in a SOT428 plastic package.

1.2 Features

- High thermal cycling performance
- High bidirectional blocking voltage capability
- Surface mounted package.

1.3 Applications

- Motor control
- Industrial and domestic lighting, heating and static switching.

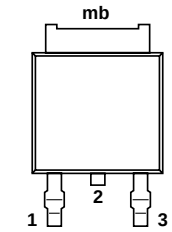
1.4 Quick reference data

- V_{DRM}, $V_{RRM} \leq 800$ V (BT151S-800R)
- V_{DRM}, $V_{RRM} \leq 650$ V (BT151S-650R)
- V_{DRM}, $V_{RRM} \leq 500$ V (BT151S-500R)
- $I_{T(RMS)} \leq 12$ A
- $I_{T(AV)} \leq 7.5$ A
- $I_{TSM} \leq 120$ A.

2. Pinning information

Table 1: Discrete pinning

Pin	Description	Simplified outline	Symbol
1	cathode (k)		
2	anode (a)		
3	gate (g)		
mb	mounting base; connected to anode (a)		



Top view

SOT428

sym037

PHILIPS

3. Ordering information

Table 2: Ordering information

Type number	Package		
	Name	Description	Version
BT151S-500R	-	plastic single-ended surface mounted package (Philips version of D-PAK); 3 leads (one lead cropped)	SOT428
BT151S-650R			
BT151S-800R			

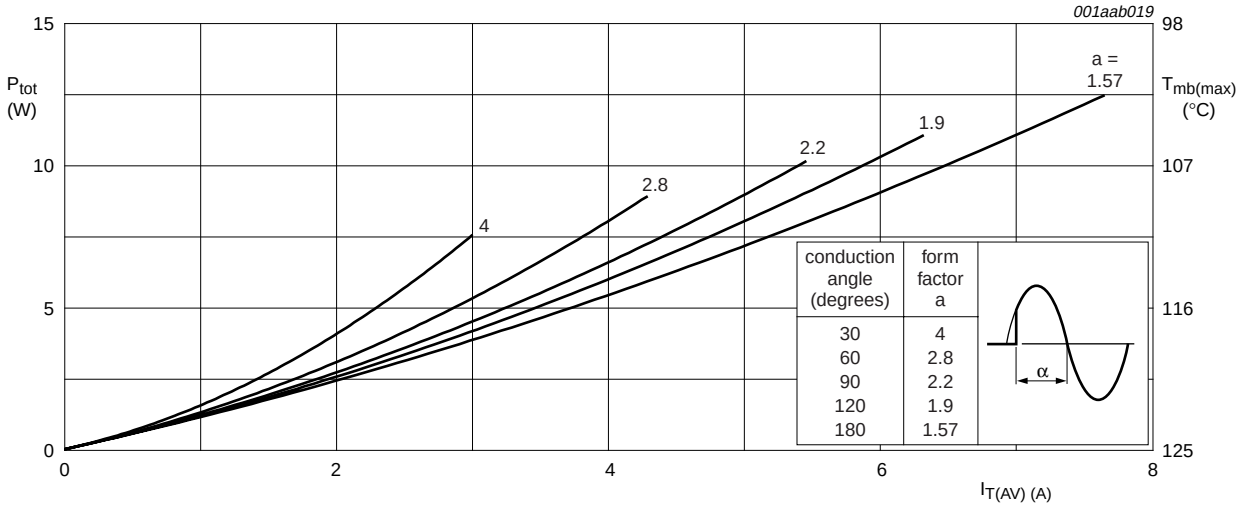
4. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

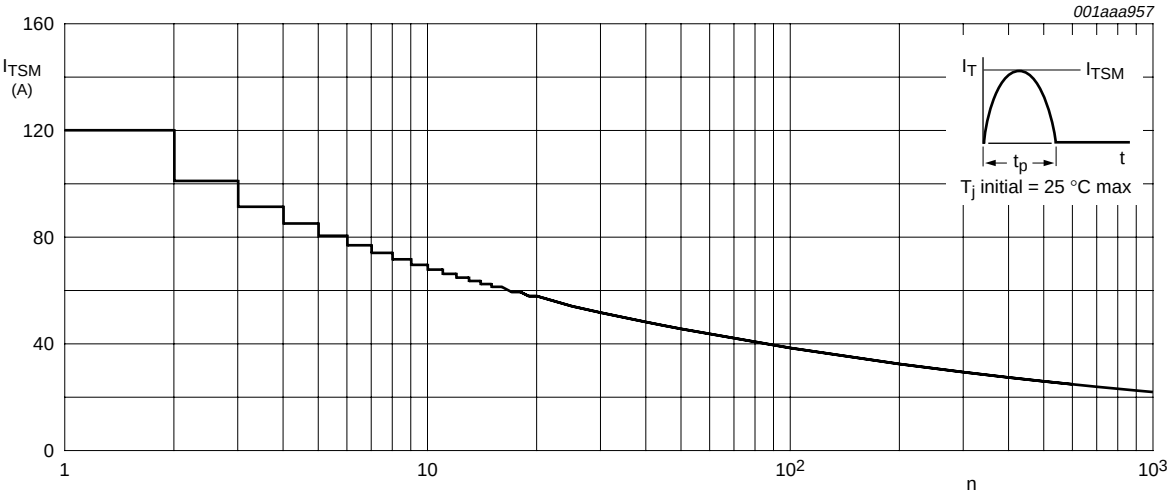
Symbol	Parameter	Conditions		Min	Max	Unit
V_{DRM}, V_{RRM}	repetitive peak off-state voltage					
	BT151S-500R		[1]	-	500	V
	BT151S-650R		[1]	-	650	V
	BT151S-800R			-	800	V
$I_{T(AV)}$	average on-state current	half sinewave; $T_{mb} \leq 103$ °C; Figure 1		-	7.5	A
$I_{T(RMS)}$	RMS on-state current	all conduction angles; Figure 4 and Figure 5		-	12	A
I_{TSM}	non-repetitive peak on-state current	half sinewave; $T_j = 25$ °C prior to surge; Figure 2 and Figure 3				
		t = 10 ms		-	120	A
		t = 8.3 ms		-	132	A
I^2t	I^2t for fusing	t = 10 ms		-	72	A^2s
dI_T/dt	repetitive rate of rise of on-state current after triggering	$I_{TM} = 20$ A; $I_G = 50$ mA; dI_G/dt 50 mA/µs		-	50	A/µs
I_{GM}	peak gate current			-	2	A
V_{RGM}	peak reverse gate voltage			-	5	V
P_{GM}	peak gate power			-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period		-	0.5	W
T_{stg}	storage temperature			–40	+150	°C
T_j	junction temperature			-	125	°C

[1] Although not recommended, off-state voltages up to 800 V may be applied without damage, but the thyristor may switch to the on-state. The rate of rise of current should not exceed 15 A/µs.



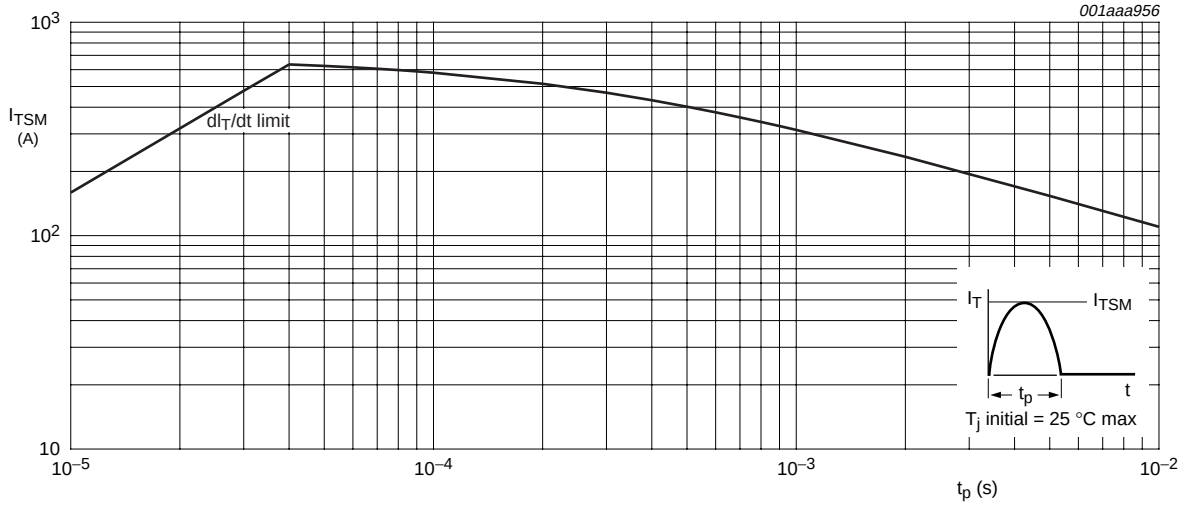
a = form factor = $I_{T(RMS)}/I_{T(AV)}$.

Fig 1. Total power dissipation as a function of average on-state current; maximum values.



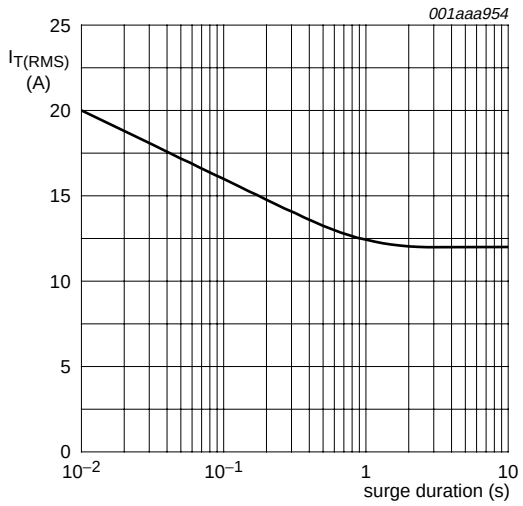
f = 50 Hz.

Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values.



$t_p \leq 10$ ms.

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values.



f = 50 Hz; $T_{mb} \leq 103$ °C.

Fig 4. RMS on-state current as a function of surge duration; maximum values.

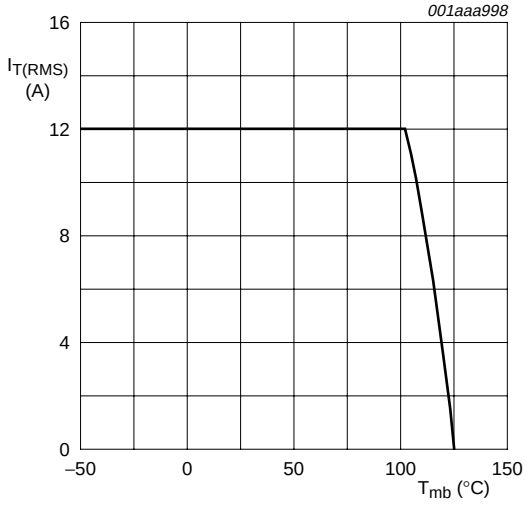


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values.

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 6	-	1.8	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on an FR4 printed-circuit board; see Figure 14	75	-	K/W

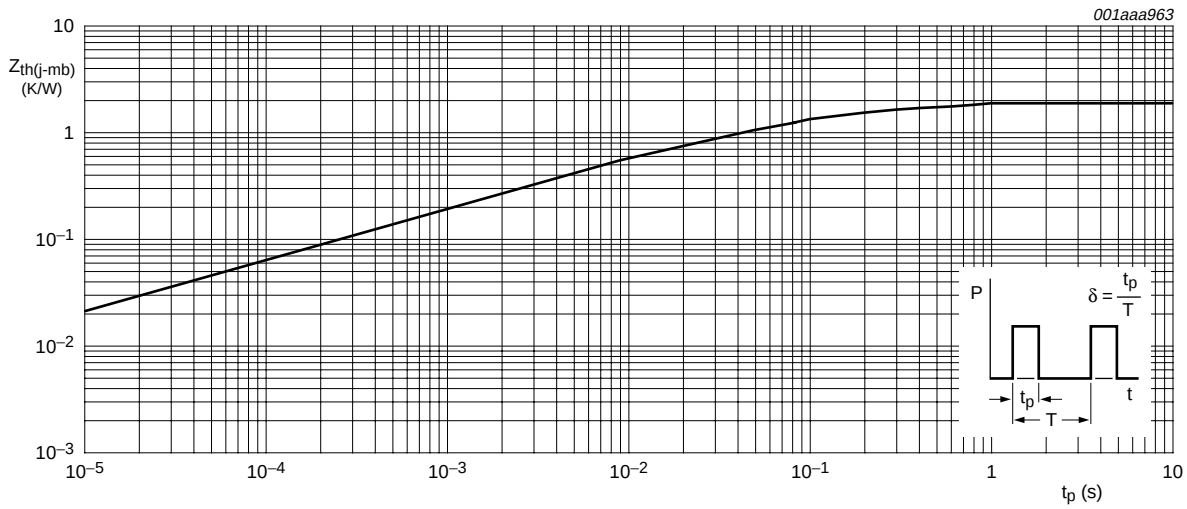


Fig 6. Transient thermal impedance as a function of pulse width.

6. Characteristics

Table 5: Characteristics

T_j = 25 °C unless otherwise stated

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
I_{GT}	gate trigger current	V_D = 12 V; I_T = 0.1 A; Figure 8	-	2	15	mA
I_L	latching current	V_D = 12 V; I_{GT} = 0.1 A; Figure 10	-	10	40	mA
I_H	holding current	V_D = 12 V; I_{GT} = 0.1 A; Figure 11	-	7	20	mA
V_T	on-state voltage	I_T = 23 A; Figure 9	-	1.4	1.75	V
V_{GT}	gate trigger voltage	V_D = 12 V; I_T = 0.1 A; Figure 7	-	0.6	1.5	V
		$V_D = V_{DRM(max)}$; I_T = 0.1 A; T_j = 125 °C	0.25	0.4	-	V
I_D, I_R	off-state leakage current	$V_D = V_{DRM(max)}$; $V_R = V_{RRM(max)}$; T_j = 125 °C	-	0.1	0.5	mA
Dynamic characteristics						
dV_D/dt	critical rate of rise of off-state voltage	V_{DM} = 67% $V_{DRM(max)}$; T_j = 125 °C; exponential waveform; Figure 12				
		gate open circuit	50	130	-	V/µs
		R_{GK} = 100 Ω	200	1000	-	V/µs
t_{gt}	gate controlled turn-on time	I_{TM} = 40 A; $V_D = V_{DRM(max)}$; I_G = 0.1 A; dI_G/dt = 5 A/µs	-	2	-	µs
t_q	circuit commuted turn-on time	V_D = 67% $V_{DRM(max)}$; T_j = 125 °C; I_{TM} = 20 A; V_R = 25 V; dI_{TM}/dt = 30 A/µs; dV_D/dt = 50 V/µs; R_{GK} = 100 Ω	-	70	-	µs

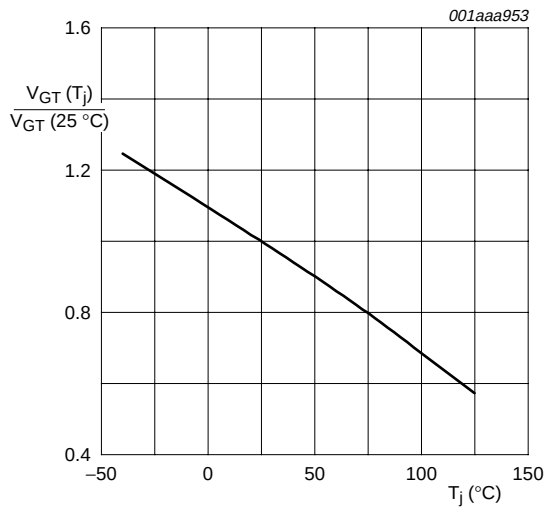


Fig 7. Normalized gate trigger voltage as a function of junction temperature.

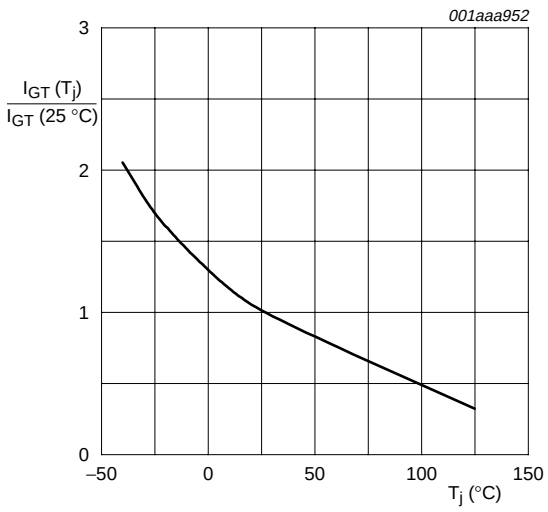
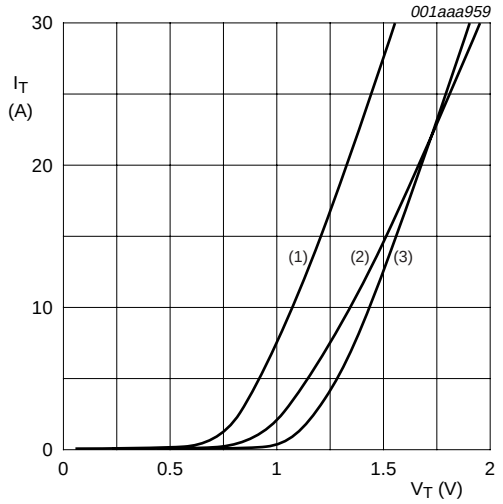


Fig 8. Normalized gate trigger current as a function of junction temperature.



V_O = 1.06 V.

R_S = 0.0304 Ω.

(1) T_j = 125 °C; typical values.

(2) T_j = 125 °C; maximum values.

(3) T_j = 25 °C; maximum values.

Fig 9. On-state current characteristics.

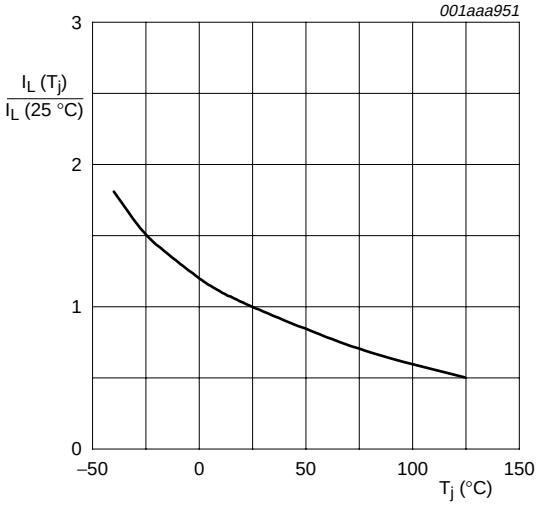


Fig 10. Normalized latching current as a function of junction temperature.

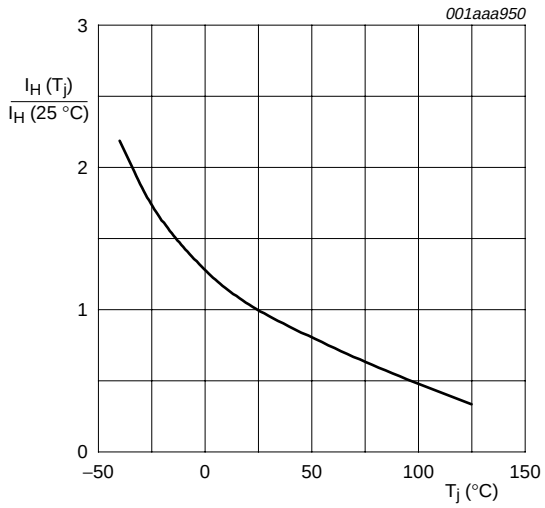
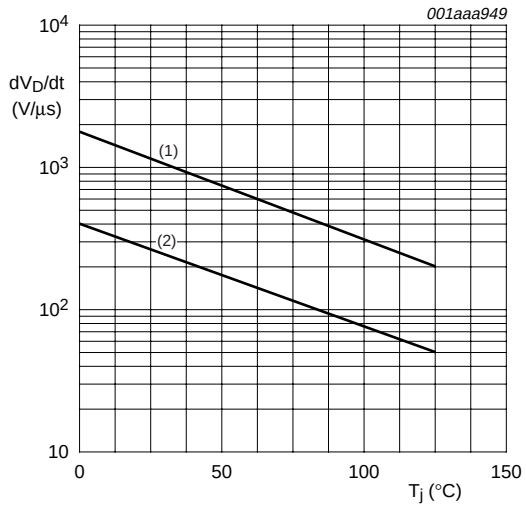


Fig 11. Normalized holding current as a function of junction temperature.



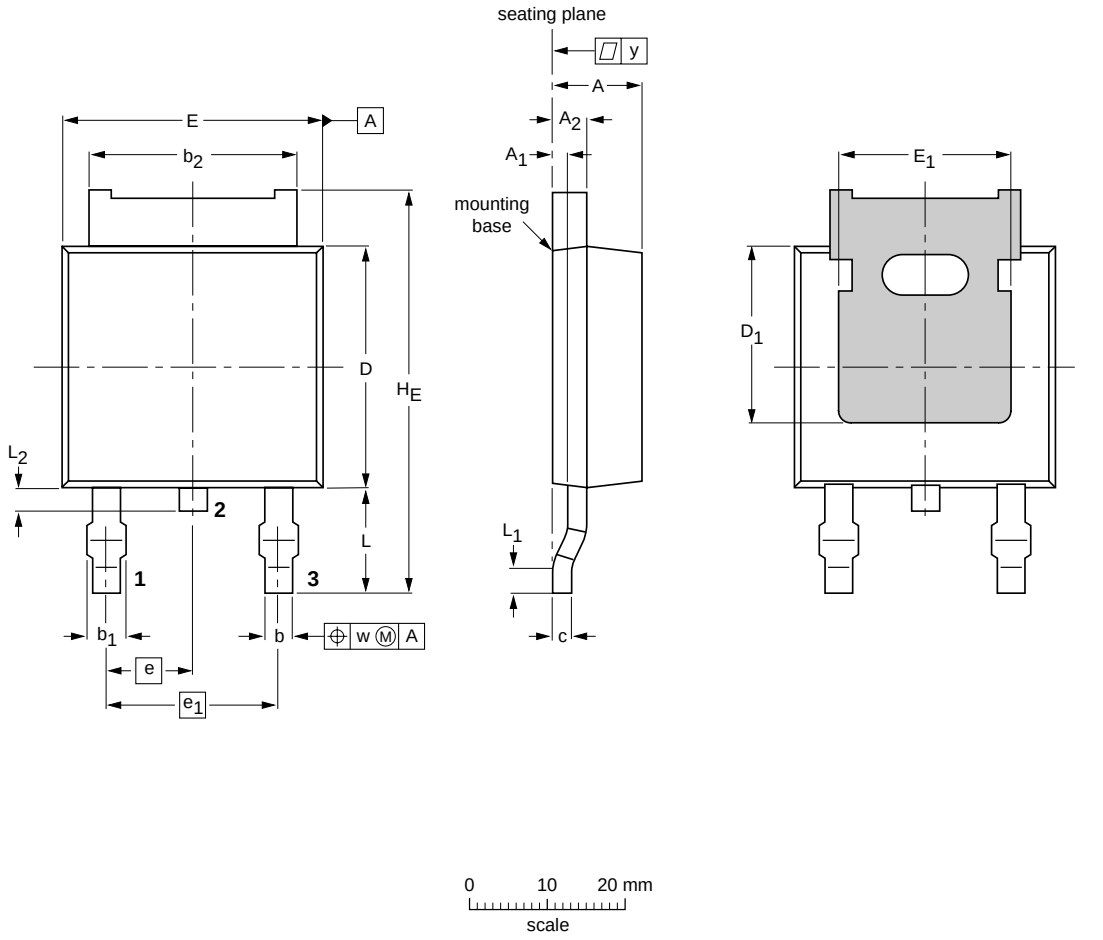
(1) R_{GK} = 100 Ω.

(2) Gate open circuit.

Fig 12. Critical rate of rise of off-state voltage as a function of junction temperature; minimum values.

7. Package outline

Plastic single-ended surface mounted package (Philips version of D-PAK); 3 leads (one lead cropped) **SOT428**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 (1)	A_2	b	b_1	b_2	c	D	D_1 min.	E	E_1	e	e_1	H_E	L	L_1 min.	L_2	w	y max.
mm	2.38 2.22	0.65 0.45	0.93 0.73	0.89 0.71	1.1 0.9	5.46 5.26	0.4 0.2	6.22 5.98	4.0	6.73 6.47	4.81 4.45	2.285	4.57	10.4 9.6	2.95 2.55	0.5	0.9 0.5	0.2	0.2

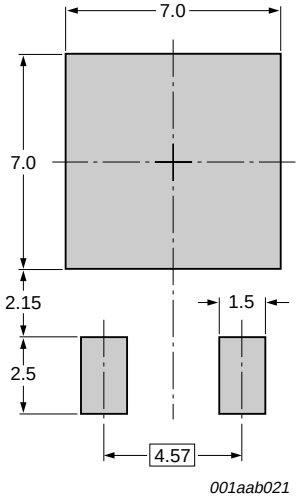
Note

1. Measured from heatsink back to lead.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT428		TO-252	SC-63			~~99-09-13~~ 01-12-11

Fig 13. Package outline.

8. Mounting



Plastic meets requirements of UL94 V-0 at $\frac{1}{8}$ inch.

Fig 14. SOT428: minimum pad size for surface mounting.

9. Revision history

Table 6: Revision history

Document ID	Release date	Data sheet status	Change notice	Order number	Supersedes
BT151S_SERIES_4	20040609	Product specification	-	9397 750 13161	BT151S_SERIES_3
Modifications:	• The format of this specification has be redesigned to comply with Philips Semiconductors' new presentation and information standard				
BT151S_SERIES_3	20020101	Product specification	-	-	BT151S_SERIES_2
BT151S_SERIES_2	19990601	Product specification	-	-	BT151S_SERIES_1
BT151S_SERIES_1	19970901	Product specification	-	-	-

10. Data sheet status

Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

11. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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14. Contents

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